

X-ray attenuation coefficients of Gd compounds in the K edge region at different energies

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The total mass attenuation coefficients for element Gd and compounds Gd_2O_3 , $Gd_2(CO_3)_2 \cdot H_2O$, $Gd_2(C_2O_4) \cdot H_2O$ and $Gd_2(SO_4)_3$ were measured at the different energies between 39.522-57.142 keV range by using secondary excitation method. Sm, Eu, Gd, Tb, Dy, Ho and Er were chosen as secondary exciter. 59.54 keV gamma rays emitted from an Am-241 annular source were used to excite secondary exciter and $K\alpha_2$, $K\alpha_1$, $K\beta_1$ and $K\beta_2$ lines emitted of secondary exciter were counted by a Si(Li) detector with a resolution of 160 eV at 5.9 keV. The validity of mixture rule was discussed around the absorption edge for compounds. Obtained values were compared with theoretical values.

Keywords: Total mass attenuation coefficient, EDXRF, Mixture rule.